

# GSM3131JZF

## 30V P-Channel MOSFET

### Product Description

The P-Channel enhancement mode power field effect transistor is using trench DMOS technology. This advanced technology has been especially tailored to minimize on-state resistance, provide superior switching performance, and withstand high energy pulse in the avalanche and commutation mode.

The device is well suited for high efficiency fast switching applications.

### Features

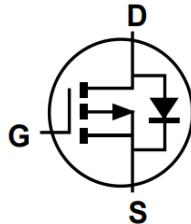
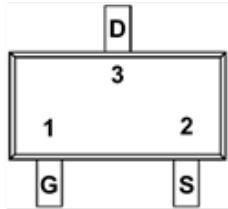
- $R_{DS(ON)}=32m\Omega @ V_{GS}=-10V$
- $R_{DS(ON)}=46m\Omega @ V_{GS}=-4.5V$
- Fast switching
- Suit for -4.5V Gate Drive Applications
- SOT-23 package design
- RoHS Compliant and Halogen Free

### Applications

- Notebook
- Load Switch
- Battery Protection
- Hand-held Instruments

### Packages & Pin Assignments

| SOT-23 |             | Equivalent Circuit |  |
|--------|-------------|--------------------|--|
| Pin    | Description |                    |  |
| 1      | Gate        |                    |  |
| 2      | Source      |                    |  |
| 3      | Drain       |                    |  |



## Ordering and Marking Information

| Ordering Information  |                                       |  |                 |
|---|---------------------------------------|--|-----------------|
| Part Number   | Package                               | Part Marking   | Quantity / Reel |
| GSM3131JZF  | SOT-23                                | 31□□□  | 3,000 PCS       |
| <b>GSM3131 1 2</b>  |                                       |  |                 |
| - Product Code:<br>GSM3131  | - Package Code:<br>1 is JZ for SOT-23 | - Green Level:<br>2 is F for RoHS Compliant and Halogen Free |                 |
| Marking Information   |                                       |  |                 |
| - Product Code:<br>31<br><br><div style="border: 1px solid black; padding: 2px; display: inline-block;">31□□□</div> - GS Code:<br>□□□ |                                       |  |                 |

## Absolute Maximum Ratings (T<sub>A</sub>=25°C, unless otherwise specified)

| Symbol           | Parameter                               | Value  | Unit      |   |
|------------------|---|--|-----------|---|
| V <sub>DSS</sub> | Drain-Source Voltage                    | -30  | V         |   |
| V <sub>GSS</sub> | Gate-Source Voltage                     | ±20  | V         |   |
| I <sub>D</sub>   | Continuous Drain Current                | T <sub>A</sub> =25°C<br>T <sub>A</sub> =70°C | -5<br>-4  | A |
| I <sub>DM</sub>  | Pulsed Drain Current <sup>1</sup>       | -20  | A         |   |
| P <sub>D</sub>   | Power Dissipation <sup>2</sup>          | T <sub>A</sub> =25°C<br>T <sub>A</sub> =70°C | 1.56<br>1 | W |
| R <sub>θJA</sub> | Thermal Resistance, Junction to Ambient | 80   | °C/W      |   |
| T <sub>J</sub>   | Operating Junction Temperature Range    | -55 to +150                                  | °C        |   |
| T <sub>STG</sub> | Storage Temperature Range               | -55 to +150                                  | °C        |   |

### NOTE:

1. Pulse width is limited by maximum junction temperature.
2. The device mounted on 1in2 FR-4 board with 2oz. Copper

## Electrical Characteristics (T<sub>A</sub>=25°C, unless otherwise specified)

| Symbol                         | Parameter                       | Test Condition  | Min. | Typ. | Max. | Unit |
|--------------------------------|---------------------------------|---|------|------|------|------|
| <b>Static Characteristics</b>  |                                 |   |      |      |      |      |
| BV <sub>DSS</sub>              | Drain-Source Breakdown Voltage  | V <sub>GS</sub> =0V, I <sub>D</sub> =-250μA   | -30  | -    | -    | V    |
| I <sub>DSS</sub>               | Zero Gate Voltage Drain Current | V <sub>DS</sub> =-30V, V <sub>GS</sub> =0V  | -    | -    | -1   | μA   |
| I <sub>GSS</sub>               | Gate-Source Leakage Current     | V <sub>DS</sub> =0V, V <sub>GS</sub> =±20V  | -    | -    | ±100 | nA   |
| V <sub>GS(th)</sub>            | Gate Threshold Voltage          | V <sub>DS</sub> =V <sub>GS</sub> , I <sub>D</sub> =-250μA                                 | -1.3 | -1.7 | -2.3 | V    |
| R <sub>DS(ON)</sub>            | Drain-Source On-Resistance      | V <sub>GS</sub> =-10V, I <sub>D</sub> =-4A<br>V <sub>GS</sub> =-4.5V, I <sub>D</sub> =-3A | -    | 27   | 32   | mΩ   |
| g <sub>FS</sub>                | Forward Transconductance        | V <sub>DS</sub> =-10V, I <sub>D</sub> =-3A  | -    | 5    | -    | S    |
| V <sub>SD</sub>                | Diode Forward Voltage           | V <sub>GS</sub> =0V, I <sub>S</sub> =-1A  | -    | -    | -1   | V    |
| <b>Dynamic Characteristics</b> |                                 |   |      |      |      |      |
| Q <sub>g</sub>                 | Total Gate Charge               |   | -    | 8    | 15   |      |
| Q <sub>gs</sub>                | Gate-Source Charge              | V <sub>DS</sub> =-15V, V <sub>GS</sub> =-4.5V, I <sub>D</sub> =-5A                        | -    | 3.3  | 6    | nC   |
| Q <sub>gd</sub>                | Gate-Drain Charge               |   | -    | 2.3  | 5    |      |
| C <sub>iss</sub>               | Input Capacitance               |   | -    | 757  | 1280 |      |
| C <sub>oss</sub>               | Output Capacitance              | V <sub>DS</sub> =-15V, V <sub>GS</sub> =0V, f=1MHz  | -    | 122  | 210  | pF   |
| C <sub>rss</sub>               | Reverse Transfer Capacitance    |   | -    | 88   | 175  |      |
| t <sub>d(on)</sub>             | Turn-On Delay Time              |   | -    | 4.6  | 9    |      |
| t <sub>r</sub>                 | Turn-On Rise Time               |   | -    | 14   | 26   |      |
| t <sub>d(off)</sub>            | Turn-Off Delay Time             | V <sub>DD</sub> =-15V, I <sub>D</sub> =-1A, V <sub>GS</sub> =-10V, R <sub>G</sub> =6Ω     | -    | 34   | 58   | ns   |
| t <sub>f</sub>                 | Turn-Off Fall Time              |   | -    | 18   | 35   |      |

## Typical Performance Characteristics

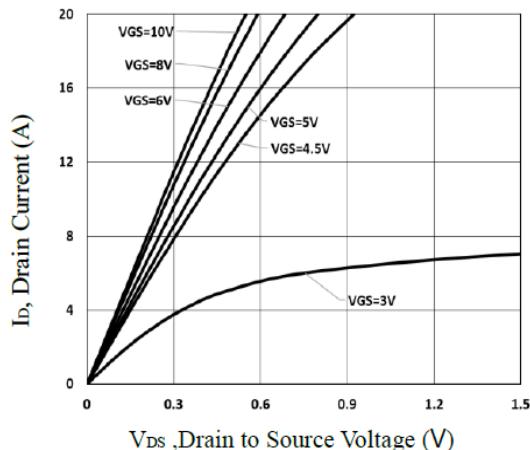


Fig.1 Typical Output Characteristics

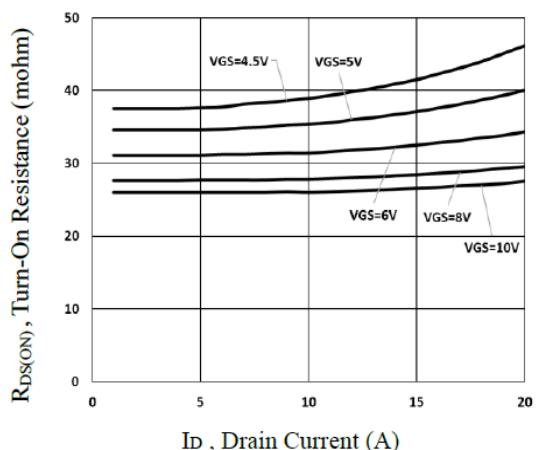


Fig.2 Turn-On Resistance vs.  $I_D$

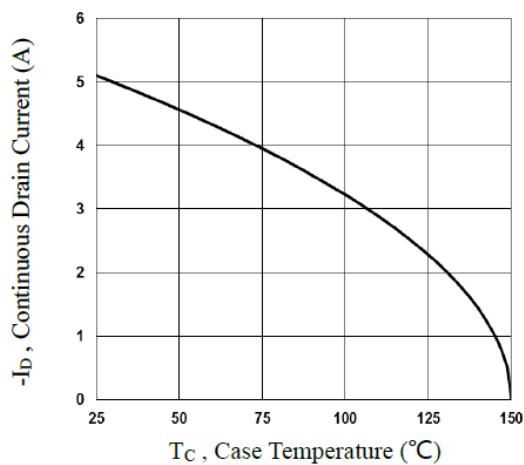


Fig.3 Continuous Drain Current vs.  $T_c$

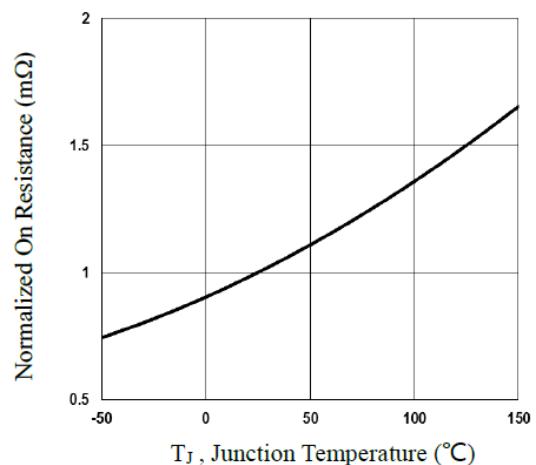


Fig.4 Normalized  $R_{DS(ON)}$  vs.  $T_J$

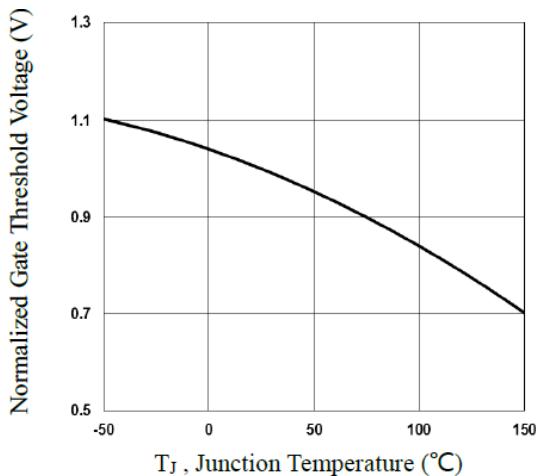


Fig.5 Normalized  $V_{th}$  vs.  $T_J$

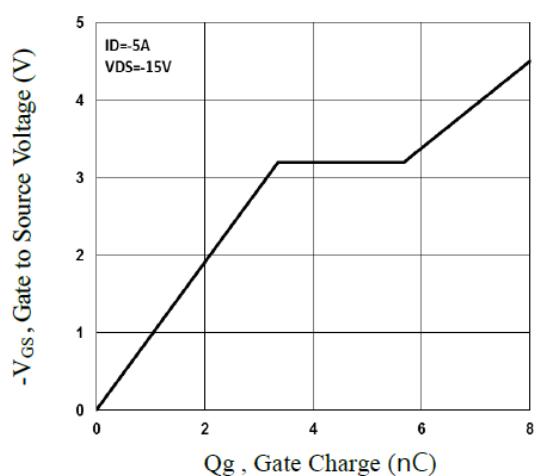


Fig.6 Gate Charge Characteristics

## Typical Performance Characteristics

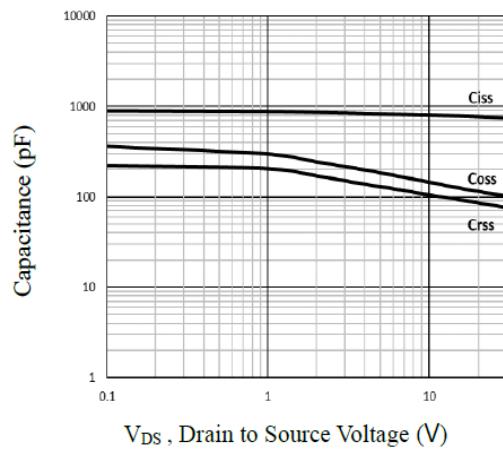


Fig.7 Capacitance Characteristics

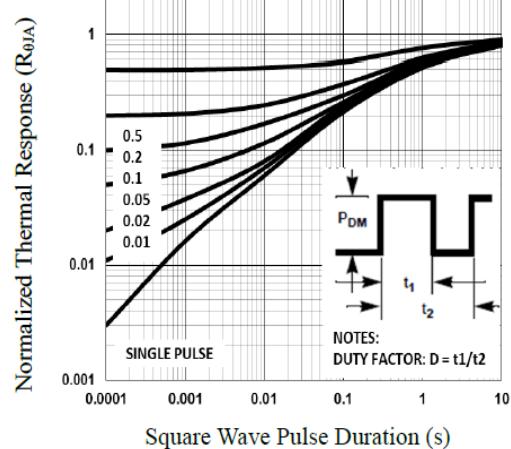


Fig.8 Normalized Transient Impedance

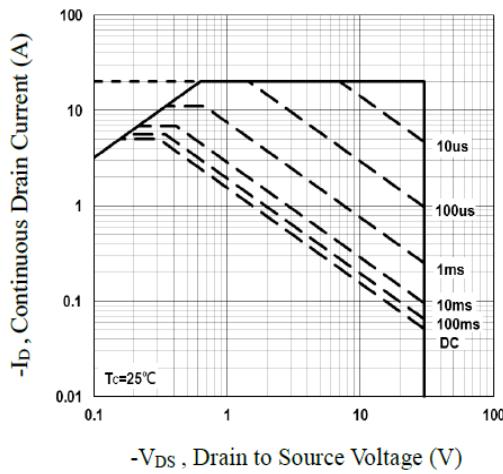
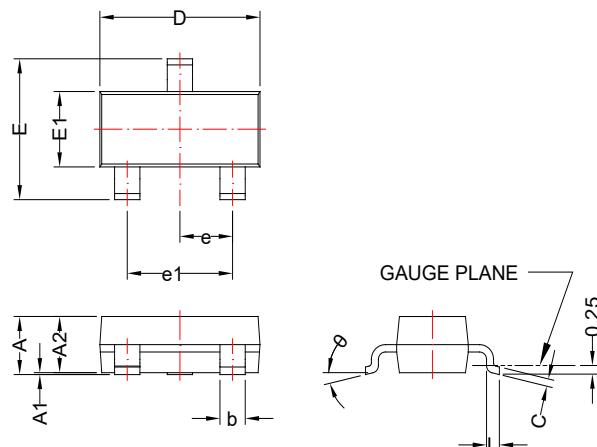


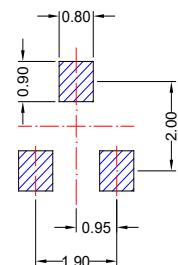
Fig.9 Maximum Safe Operation Area

# SOT-23

## Package Dimension



## Recommended Land Pattern



## Dimensions

| Symbol    | Millimeters |      | Inches    |       |
|-----------|-------------|------|-----------|-------|
|           | Min         | Max  | Min       | Max   |
| <b>A</b>  | 0.75        | 1.17 | 0.030     | 0.046 |
| <b>A1</b> | 0.01        | 0.15 | 0.000     | 0.006 |
| <b>A2</b> | 0.70        | 1.02 | 0.028     | 0.040 |
| <b>b</b>  | 0.30        | 0.50 | 0.012     | 0.020 |
| <b>c</b>  | 0.08        | 0.20 | 0.003     | 0.008 |
| <b>D</b>  | 2.80        | 3.04 | 0.110     | 0.120 |
| <b>E</b>  | 2.10        | 2.64 | 0.083     | 0.104 |
| <b>E1</b> | 1.20        | 1.40 | 0.047     | 0.055 |
| <b>e</b>  | 0.95 BSC    |      | 0.037 BSC |       |
| <b>e1</b> | 1.90 BSC    |      | 0.075 BSC |       |
| <b>L</b>  | 0.3         | 0.6  | 0.012     | 0.024 |
| <b>θ</b>  | 0°          | 8°   | 0°        | 8°    |

### NOTE:

Dimensions are exclusive of Burrs, Mold Flash & Tie Bar extrusions.

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